IN THE CLAIMS

This listing of claims will replace all prior versions, and listings, of claims in the application:

- 1 (Currently Amended) A current-in-plane (CIP) GMR sensor, comprising:
- a GMR sensor stack having a width selected to provide a predetermined track
- 3 width;
- a spacer layer, having a width substantially equal to the spin valve stack, formed
- 5 over a free-layer of the GMR sensor stack; and
- an in-stack biasing layer disposed over the spacer and having a width substantially
- 7 equal to the width of the GMR sensor stack; and
- 8 an antiferromagnetic layer formed on both sides of the in-stack biasing layer to
- 9 provide an off-track bias layer.
- 1 2. (Previously Presented) The CIP GMR sensor of claim 1, wherein
- 2 the in-stack biasing layer comprises materials selected from the group consisting of NiFe,
- 3 CoFe, NiFeCr, NiFeX and CoFeX.
- 1 3. (Canceled)
- 1 4. (Currently Amended) The CIP GMR sensor of claim [[3]] 1, further
- 2 comprising lead layers formed on either side of the GMR sensor stack, wherein the lead
- 3 layers comprises a layer of Rhodium disposed adjacent to the GMR sensor stack and a
- 4 Tantalum layer formed over the layer of Rhodium.

Application No.: 10/811,524

Docket No. HSJ920040003US1/(HGST075-0544)

Date of Response: May 29, 2007

Reply to Office Action Dated February 26, 2007

- 5. (Currently Amended) The CIP GMR sensor of claim [[3]] 1, wherein the antiferromagnetic layer comprises a layer of Platinum-Manganese.
- 1 6. (Currently Amended) The CIP GMR sensor of claim [[3]] 1, wherein the
- 2 in-stack biasing layer comprises a bias layer formed only over the spacer and a coupling
- 3 layer formed over the bias layer and the antiferromagnetic layer.
- 1 7. (Previously Presented) The CIP GMR sensor of claim 6, wherein
- 2 the bias layers and coupling layer each comprise a material selected from the group
- 3 consisting of NiFe, CoFe, NiFeCr, NiFeX and CoFeX.
- 1 8. (Original) The CIP GMR sensor of claim 1 further comprising a cap
- 2 layer formed over the in-stack bias layer.

Application No.: 10/811,524 Docket No. HSJ920040003US1/(HGST075-0544) Date of Response: May 29, 2007 Reply to Office Action Dated February 26, 2007

1	9. (Currently Amended) A magnetic storage system, comprising:
2	a magnetic storage medium having a plurality of tracks for recording of data; and
3	a current-in-plane (CIP) GMR sensor maintained in a closely spaced position
4	relative to the magnetic storage medium during relative motion between the magnetic
5	transducer and the magnetic storage medium, the CIP GMR sensor further comprising:
6	a GMR sensor stack having a width selected to provide a predetermined
7	track width;
8	a spacer layer, having a width substantially equal to the spin valve stack,
9	formed over a free-layer of the GMR sensor stack; and
10	an in-stack biasing layer disposed over the spacer and having a width
11	substantially equal to the width of the GMR sensor stack; and
12	an antiferromagnetic layer formed on both sides of the in-stack biasing
13	layer to provide an off-track bias layer.
1	10. (Previously Presented) The magnetic storage of claim 9, wherein
2	the in-stack biasing layer comprises materials selected from the group consisting of NiFe,
3	CoFe, NiFeCr, NiFeX and CoFeX.
1	11. (Canceled)

Application No.: 10/811,524

Docket No. HSJ920040003US1/(HGST075-0544)

Date of Response: May 29, 2007

Reply to Office Action Dated February 26, 2007

- 1 12. (Currently Amended) The magnetic storage of claim [[11]] 9, , further
- 2 comprising lead layers formed on either side of the GMR sensor stack, wherein the lead
- 3 layers comprises a layer of Rhodium disposed adjacent to the GMR sensor stack and a
- 4 Tantalum layer formed over the layer of Rhodium.
- 1 13. (Currently Amended) The magnetic storage of claim [[11]] 9, wherein
- 2 the antiferromagnetic layer comprises a layer of Platinum-Manganese.
- 1 14. (Currently Amended) The magnetic storage of claim [[11]] 9, wherein
- 2 the in-stack biasing layer comprises a bias layer formed only over the spacer and a
- 3 coupling layer formed over the bias layer and the antiferromagnetic layer.
- 1 15. (Currently Amended) The magnetic storage of claim [[9]] 14, wherein
- 2 the bias layer and the coupling layer each comprise a material selected from the group
- 3 consisting of NiFe, CoFe, NiFeCr, NiFeX and CoFeX.
- 1 16. (Original) The magnetic storage of claim 9 further comprising a cap
- 2 layer formed over the in-stack bias layer.

Application No.: 10/811,524

Docket No. HSJ920040003US1/(HGST075-0544)

Date of Response: May 29, 2007

Reply to Office Action Dated February 26, 2007

1 17. (Currently Amended) A method for providing a current-in-plane (CIP) 2 GMR sensor with an improved in-stack bias layer with a thinner sensor stack, 3 comprising; 4 forming a thin spin valve stack having a width selected to provide a 5 predetermined track width; 6 forming a spacer over the spin valve stack, the spacer having a width substantially 7 equal to the spin valve stack; 8 forming lead layers in a passive region outside the track; 9 forming, over the spacer, an in-stack bias layer having a width substantially equal 10 to the width of the GMR sensor stack for biasing a free-layer of the spin valve stack; and 11 forming a cap over the bias layer; and 12 forming an antiferromagnetic layer on both sides of the in-stack biasing layer to 13 provide an off-track bias layer. 1 18. (Previously Presented) The method of claim 17, wherein forming 2 the lead layers further comprises forming a layer of Rhodium disposed adjacent to the 3 GMR sensor stack and forming a Tantalum layer formed over the layer of Rhodium. 1 19. (Previously Presented) The method of claim 17, wherein the 2 forming of the in-stack bias layer comprises forming a layer of Platinum-Manganese.

Application No.: 10/811,524 Docket No. HSJ920040003US1/(HGST075-0544)

Date of Response: May 29, 2007

Reply to Office Action Dated February 26, 2007

- 1 20. (Previously Presented) The method of claim 17, wherein the in-
- 2 stack bias layer comprises a bias layer formed only over the spacer and a coupling layer
- 3 formed over the bias layer and the antiferromagnetic layer.
- 1 21. (Currently Amended) The method of claim [[17]] 20, wherein the
- 2 forming of the bias layer and the coupling layer each further comprises using a material
- selected from the group consisting of NiFe, CoFe, NiFeCr, NiFeX and CoFeX. 3